

**Notice of References Cited**

Application/Control No.

10/539,109

Applicant(s)/Patent Under  
Reexamination  
YOSHINO ET AL.

Examiner

Quang T. Van

Art Unit

3742

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0216732	11-2004	McFadden, David H.	126/021.00A
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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